Search Notes

Application/Control No.	No. Applicant(s)/Patent under Reexamination	
09/621,020	TENCA ET AL.	
Examiner	Art Unit	
Christopher A. Revak	2131	

Christopher A. Revak

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SEARCHED					
Class	Subclass	Date	Examiner		
380	28	6/27/2005	CR		
708	491	6/27/2005	CR		
		V			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
BRS Text Search USPAT, DERWENT, JPO, EPO, IBM TDB, US PGPUB, USOCR	6/27/2005	CR	